2SB1589

Silicon PNP epitaxial planar type

For low-frequency output amplification

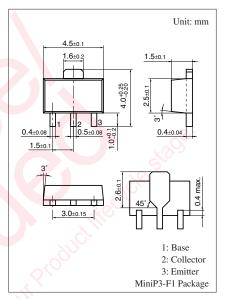
■ Features

- Low collector-emitter saturation voltage V_{CE(sat)}
- Large collector power dissipation P_C
- Mini Power type package, allowing downsizing of the equipment and automatic insertion through the tape packing and the magazine packing.

■ Absolute Maximum Ratings $T_a = 25^{\circ}C$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	V_{CBO}	-10	V
Collector-emitter voltage (Base open)	V_{CEO}	-10	V
Emitter-base voltage (Collector open)	V_{EBO}	-7	V
Collector current	I_{C}	-1.5	A
Peak collector current	I_{CP}	-2	A
Collector power dissipation *	P _C	1	W
Junction temperature	T _j	150	°C
Storage temperature	T _{stg}	-55 to +150	°C

Note) *: Print circuit board: Copper foil area of 1 cm² or more, and the board thickness of 1.7 mm for the collector portion



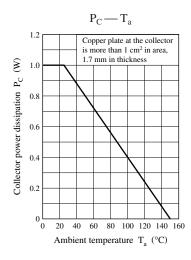
Marking Symbol: 1U

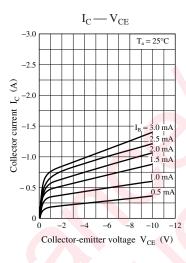
■ Electrical Characteristics $T_a = 25$ °C ± 3 °C

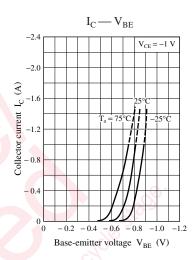
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emiter open)	V_{CBO}	$I_C = -10 \mu\text{A}, I_E = 0$	-10			V
Collector-emitter voltage (Base open)	V _{CEO}	$I_C = -1 \text{ mA}, I_B = 0$	-10			V
Emiter-base voltage (Collector open)	V_{EBO}	$I_E = -10 \mu\text{A}, I_C = 0$	-7			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = -7 \text{ V}, I_E = 0$			-1	μΑ
Forward current transfer ratio *1	h_{FE}	$V_{CE} = -1 \text{ V}, I_{C} = -400 \text{ mA}$	200		700	_
Collector-emitter saturation voltage *1	V _{CE(sat)}	$I_C = -1 \text{ A}, I_B = -25 \text{ mA}$		- 0.24	- 0.35	V
Transition frequency	f_T	$V_{CB} = -6 \text{ V}, I_E = 50 \text{ mA}, f = 200 \text{ MHz}$		190		MHz
Collector output capacitance (Common base, input open circuited)	C _{ob}	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		65		pF
Forward voltage *2	$V_{\rm F}$	$I_F = -500 \text{ mA}$			-1.3	V

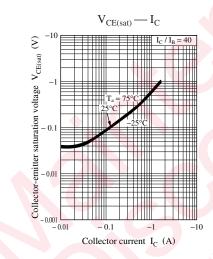
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

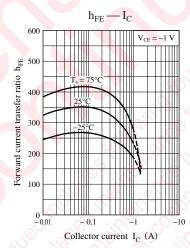
- 2. *1: Pulse measurement
 - *2: Applicable to the built-in diode

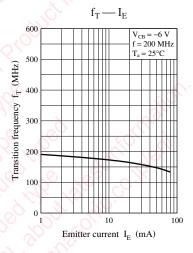


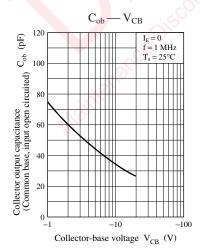












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